## SN541280 USA1545280, SN74125286, SN74S280 9-BIT ODD/EVEN PARITY GENERATORS/CHECKERS

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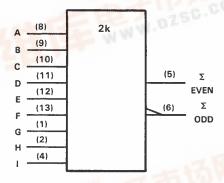
- Generates Either Odd or Even Parity for Nine Data Lines
- Cascadable for n-Bits
- Can Be Used to Upgrade Existing Systems using MSI Parity Circuits
- Typical Data-to-Output Delay of Only 14 ns for 'S280 and 33 ns for 'LS280
- Typical Power Dissipation: 'LS280 . . . 80 mW 'S280 . . . 335 mW

#### **FUNCTION TABLE**

NUMBER OF INPUTS A	OUTP	UTS
THRU I THAT ARE HIGH	ΣEVEN	$\Sigma$ ODD
0, 2, 4, 6, 8	Н	L
1, 3, 5, 7, 9	L	Н

H = high level, L = low level

#### logic symbol†



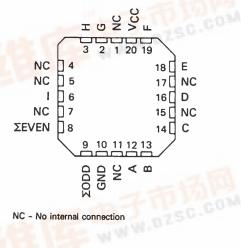
<sup>&</sup>lt;sup>†</sup>This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

#### **SN54LS280, SN54S280...J OR W PACKAGE SN74LS280, SN74S280...D OR N PACKAGE** (TOP VIEW)



SN54LS280, SN54S280 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

## description

These universal, monolithic, nine-bit parity generators/checkers utilize Schottky-clamped TTL high-performance circuitry and feature odd/even outputs to faciliate operation of either odd or even parity application. The word-length capability is easily expanded by cascading as shown under typical application data.

Series 54LS/74LS and Series 54S/74S parity generators/checkers offer the designer a trade-off between reduced power consumption and high performance. These devices can be used to upgrade the performance of most systems utilizing the '180 parity generator/checker. Although the 'LS280 and 'S280 are implemented without expander inputs, the corresponding function is provided by the availability of an input at pin 4 and the absence of any internal connection at pin 3. This permits the 'LS280 and 'S280 to be substituted for the '180 in existing designs to produce an identical function even if 'LS280's and 'S280's are mixed with existing '180's.

These devices are fully compatible with most other TTL circuits. All 'LS280 and 'S280 inputs are buffered to lower the drive requirements to one Series 54LS/74LS or Series 54S/74S standard load, respectively.

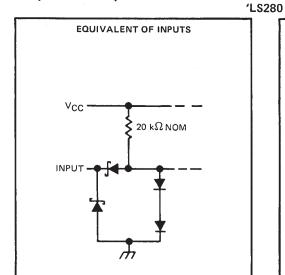


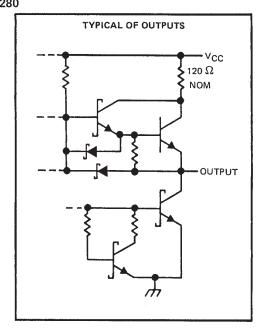


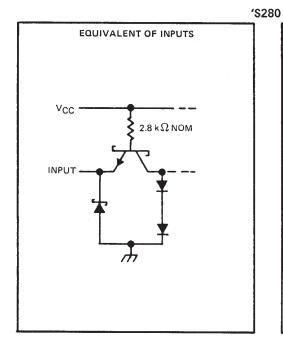
# SN54LS280, SN54S280, SN74LS280, SN74S280 9-BIT ODD/EVEN PARITY GENERATORS/CHECKERS

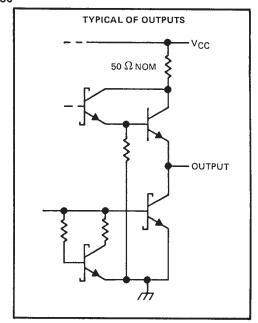
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### schematics of inputs and outputs









## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage (see Note 1)	
Input voltage: 'LS280	
'\$280	
Operating free-air temperature range: SN54'	
SN74'	0°C to 70°C
Storage temperature range	
NOTE 1: Voltage values are with respect to network ground terminal.	

# SN54LS280, SN54S280, SN74LS280, SN74S280 9-BIT ODD/EVEN PARITY GENERATORS/CHECKERS

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recommended operating conditions

		S	SN54LS280			SN74LS280			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	V	
$V_{IH}$	High-level input voltage	2	····		2			V	
VIL	Low-level input voltage			0.7			8.0	V	
ЮН	High-level output current			- 0.4			- 0.4	mA	
loL	Low-level output current			4			8	mA	
$T_A$	Operating free-air temperature	- 55		125	0		70	°C	

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SI	V54LS2	80	SI	80	Tunit		
·Allancien			MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
VIK	V <sub>CC</sub> = MIN,	$I_1 = -18 \text{ mA}$				1.5			<b>–</b> 1.5	V
V <sub>OH</sub>	V <sub>CC</sub> = MIN, V <sub>IL</sub> = MAX,	V <sub>IH</sub> = 2 V, I <sub>OH</sub> = - 0.4 m/	Α	2.5	3.4		2.7	3.4		٧
VOL	V <sub>CC</sub> = MIN, V <sub>II</sub> = MAX	V <sub>IH</sub> = 2 V,	I <sub>OL</sub> = 4 mA		0.25	0.4		0.25	0.4	V
l <sub>1</sub>	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 7 V	1.05 0			0.1		0.00	0.1	mA
lін	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 2.7 V				20		· · · · · · · · · · · · · · · · · · ·	20	μΑ
կլ	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0.4 V				- 0.4			- 0.4	mA
los§	V <sub>CC</sub> = MAX			- 20		100	- 20		100	mA
Icc	V <sub>CC</sub> = MAX,	See Note 2			16	27		16	27	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2:  $I_{\mbox{\footnotesize{CC}}}$  is measured with all inputs grounded and all outputs open.

# switching characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tpLH	Data	$\Sigma$ Even $C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega,$	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega,$ Inputs not under test at 0 V, See Note 3	33	50		
<sup>t</sup> PHL					29	45	ns
<sup>t</sup> PLH	Data	Σ Odd			23	35	
tPHL		- Odd	Jee Note 3		31	50	ns

 $<sup>\</sup>P_{\mathsf{tp}_{\mathsf{LH}}}$   $\equiv$  propagation delay time, low-to-high-level output;  $\mathsf{tp}_{\mathsf{HL}}$   $\equiv$  propagation delay time, high-to-low-level output NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



<sup>‡</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C. § Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

## SN54LS280, SN54S280, SN74LS280, SN74S280 9-BIT ODD/EVEN PARITY GENERATORS/CHECKERS

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#### recommended operating conditions

	S	SN54S280			SN74S280		
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Supply voltage, V <sub>CC</sub>	4.5	5	5.5	4.75	5	5.25	V
High-level output current, IOH			-1			-1	mA
Low-level output current, IOL			20			20	mA
Operating free-air temperature, TA	-55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITION	S†	MIN	TYP‡	MAX	UNIT
VIH	High-level input voltage			2			V
VIL	Low-level input voltage				***************************************	0.8	V
VIK	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -18 mA				-1.2	V
Vон	High-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V,	SN54S'	2.5	3.4		
* OH	Thigh-level output voltage	V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -1 mA	SN74S'	2.7	3,4		V
VOL	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V,				0.5	V
JOL		V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 20 mA			0.5	"	
Ц	Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V				1	mA
<sup>‡</sup> IH	High-level input current	V <sub>CC</sub> = MAX, V <sub>1</sub> = 2.7 V				50	μА
IL	Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.5 V				-2	mA
los	Short-circuit output current§	V <sub>CC</sub> = MAX		-40	***************************************	-100	mA
		VMAY GN	SN54S280		67	99	
loo	Supply current	V <sub>CC</sub> = MAX, See Note 2	SN74S280		67	105	mA
ICC	ouppry current	V <sub>CC</sub> = MAX, T <sub>A</sub> = 125°C, See Note 2	SN54S280N			94	mA

<sup>&</sup>lt;sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

# switching characteristics, $V_{CC}$ = 5 V, $T_A$ = 25°C

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<sup>t</sup> PLH	Data	Σ Even			14	21	
<sup>t</sup> PHL	Data	20 to VC11	$C_L = 15  pF$ , $R_L = 280  \Omega$ ,		11.5	18	ns
<sup>t</sup> PLH	Data	Σ Odd	See Note 3		14	21	
tPHL the transfer of the trans	Data	2 Odd			11.5	18	ns

 $<sup>\</sup>P_{\text{tpLH}}$  = propagation delay time, low-to-high-level output:  $\text{tp}_{\text{HL}}$  = propagation delay time, high-to-low-level output NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

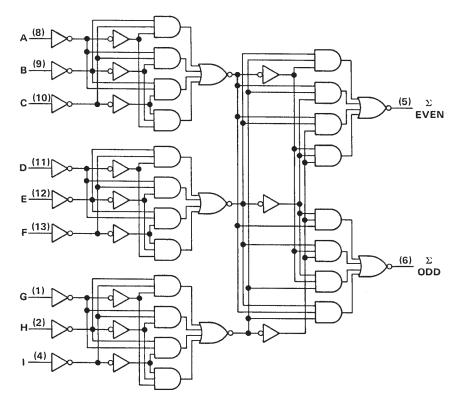


 $<sup>^{\</sup>ddagger}$ All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_{A} = 25^{\circ}$ C.

Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

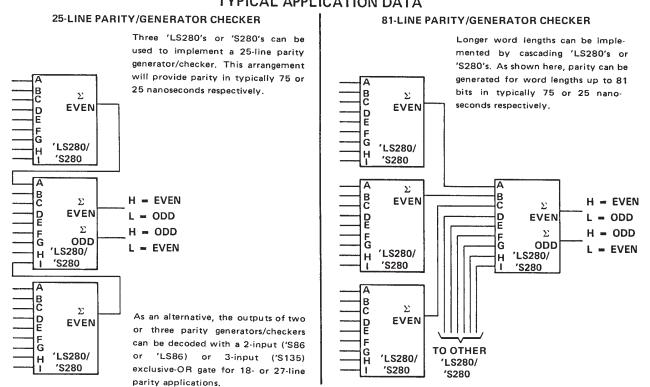
NOTE 2: ICC is measured with all inputs grounded and all outputs open.

### logic diagram (positive logic)



Pin numbers shown are for D, J, N, and W packages.

#### TYPICAL APPLICATION DATA





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